# Application/Control No. Applicant(s)/Patent Under Reexamination HEGDE ET AL. Examiner Asok K. Sarkar Art Unit Page 1 of 1

# Notice of References Cited

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,292.673	03-1994	Shinriki et al.	438/287
	В	US-6,407,435	06-2002	Ma et al.	257/411
	С	US-2001/0013629	08-2001	Bai	257/411
	D	US-2001/0053601	12-2001	Mogami	438/658
	Е	US-2002/0115252	08-2002	Haukka et al.	438/240
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	j	US-			
	к	US-			
	L	US-			
	М	US-			

### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р		A - 1			
	Q					
	R					
	S					
	Т					

### NON-PATENT DOCUMENTS

	HON I AILIN BOOMENTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.